

Figure 1

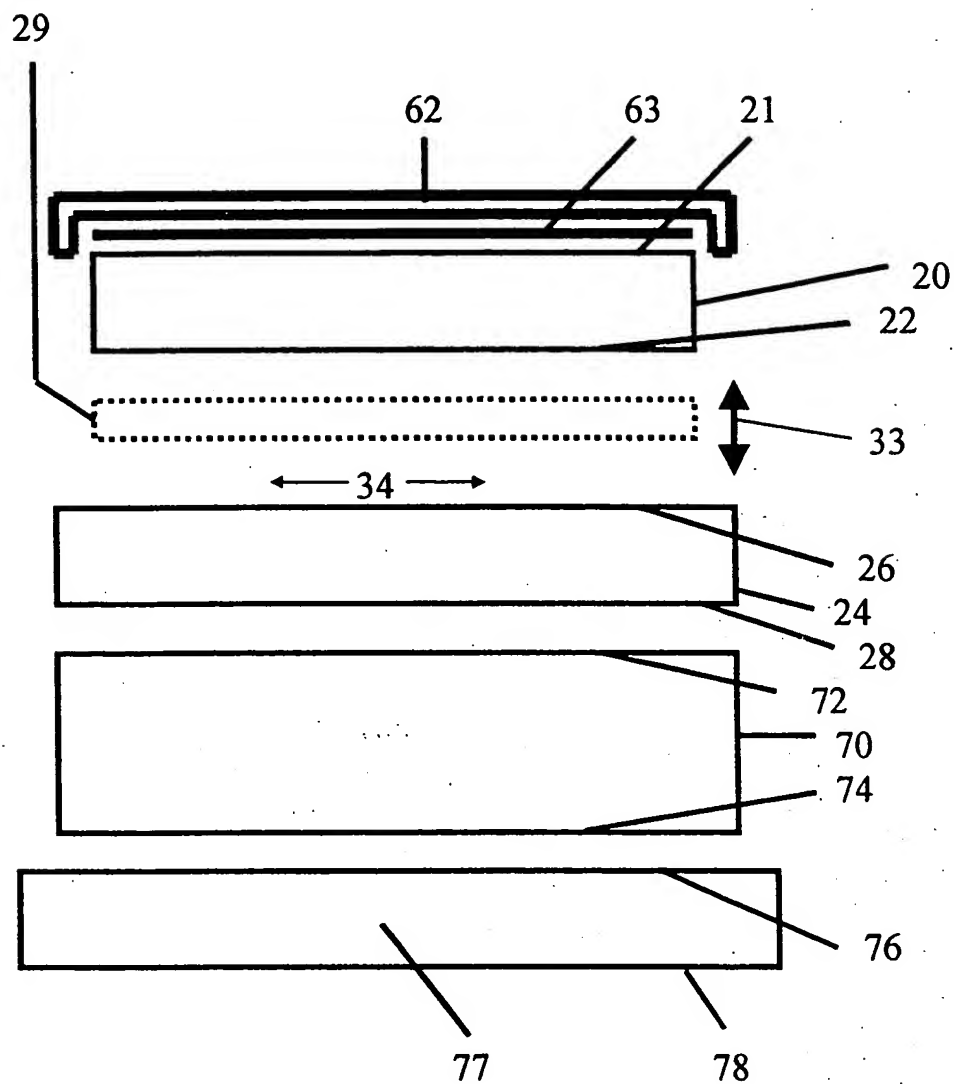


Figure 2

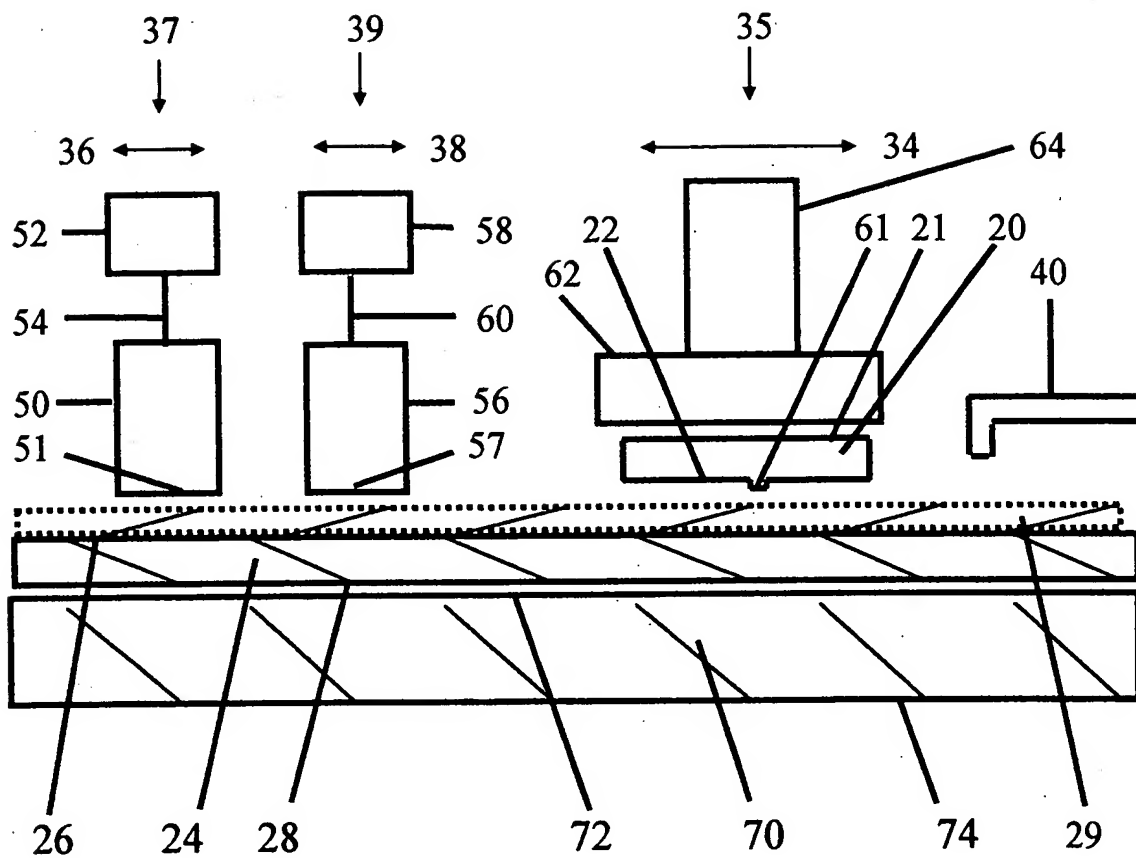


Figure 3

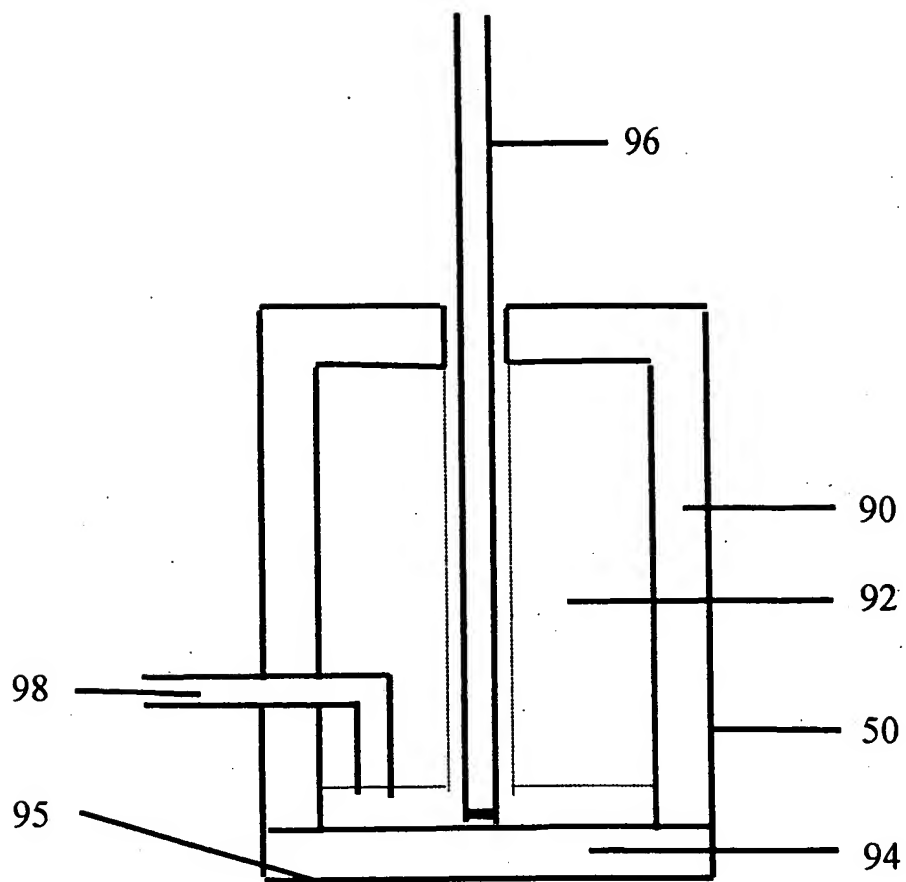


Figure 4

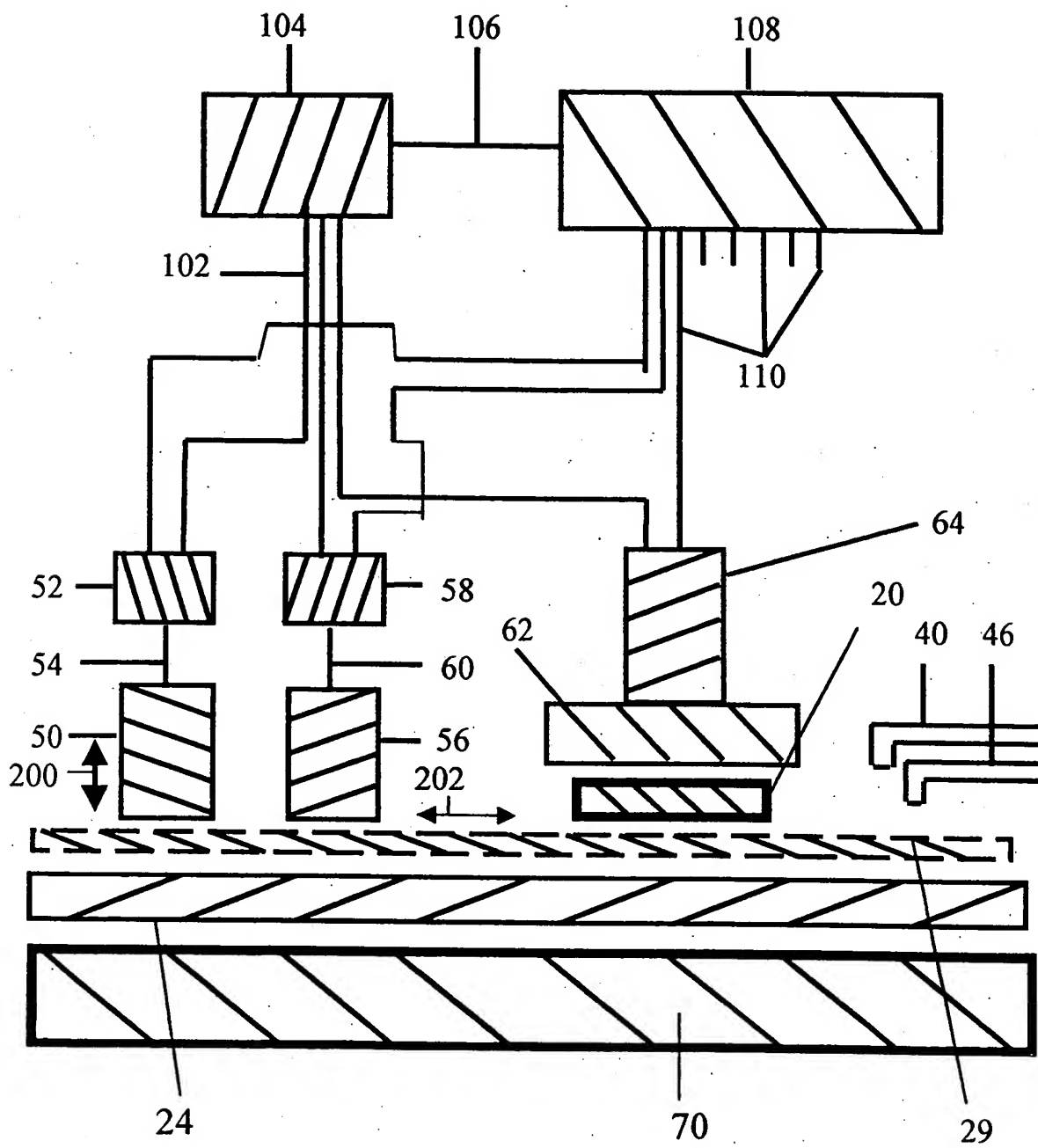


Figure 5

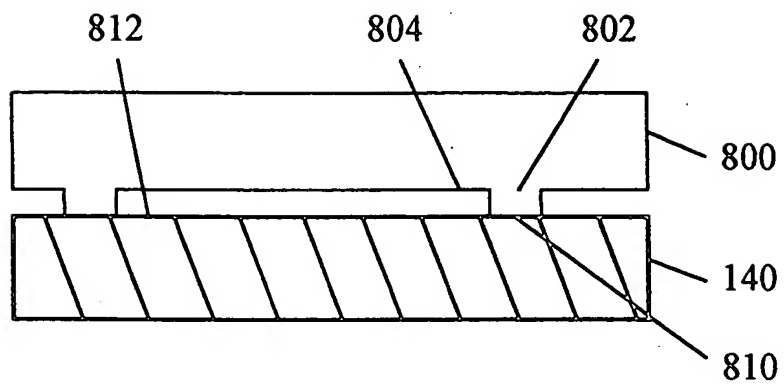


Fig. 6a

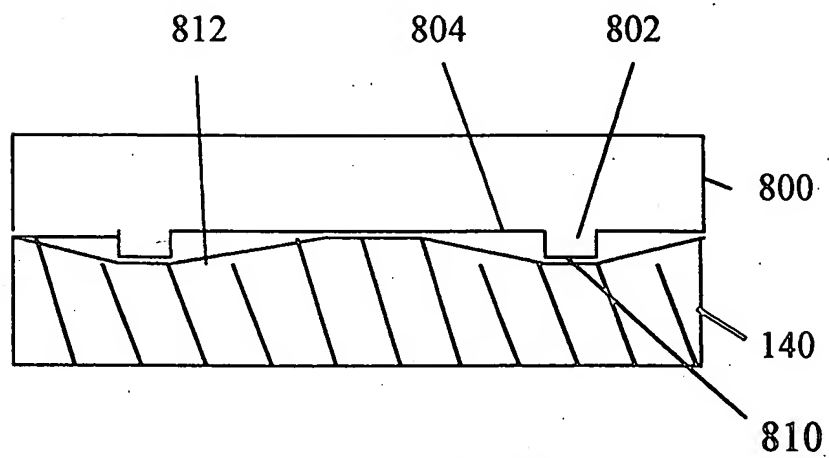


Fig. 6b

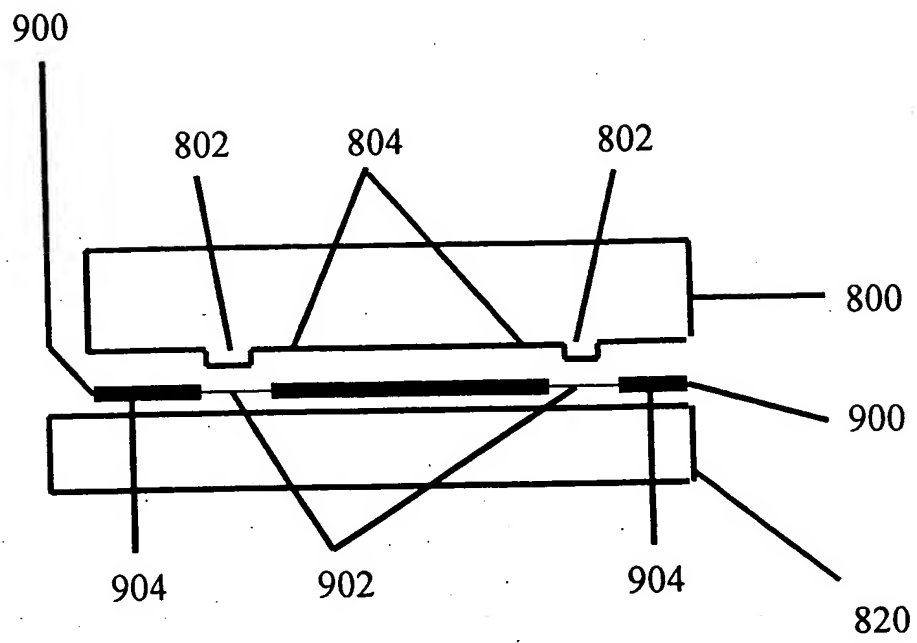
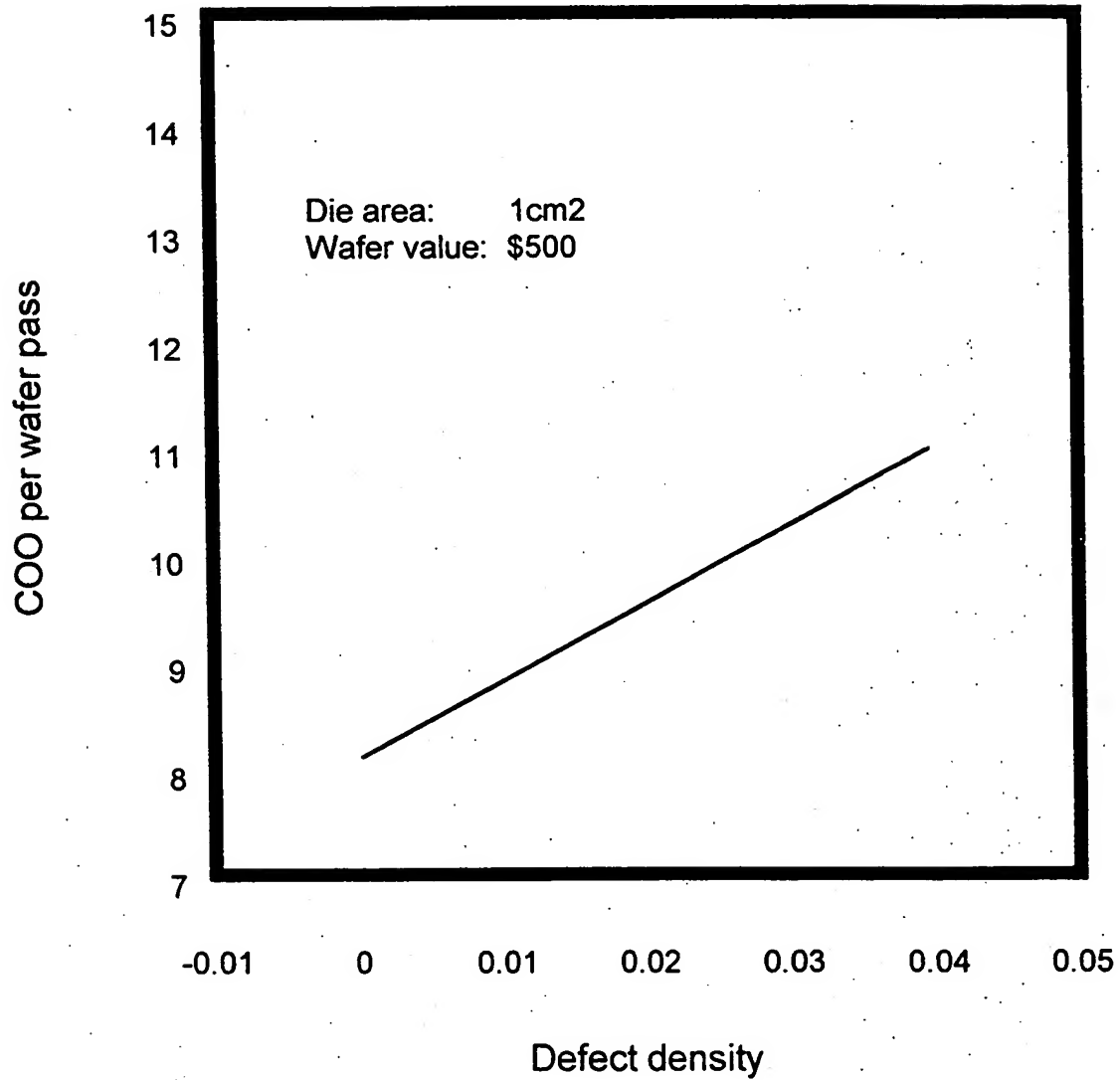
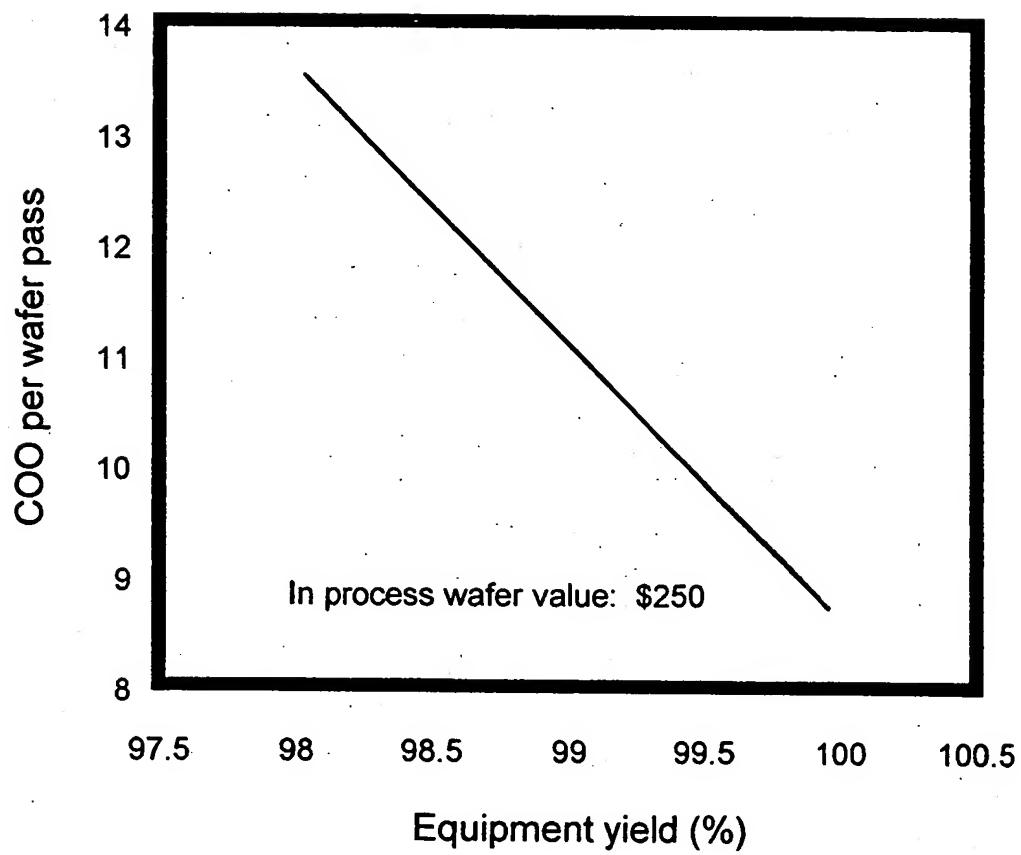


Figure 7

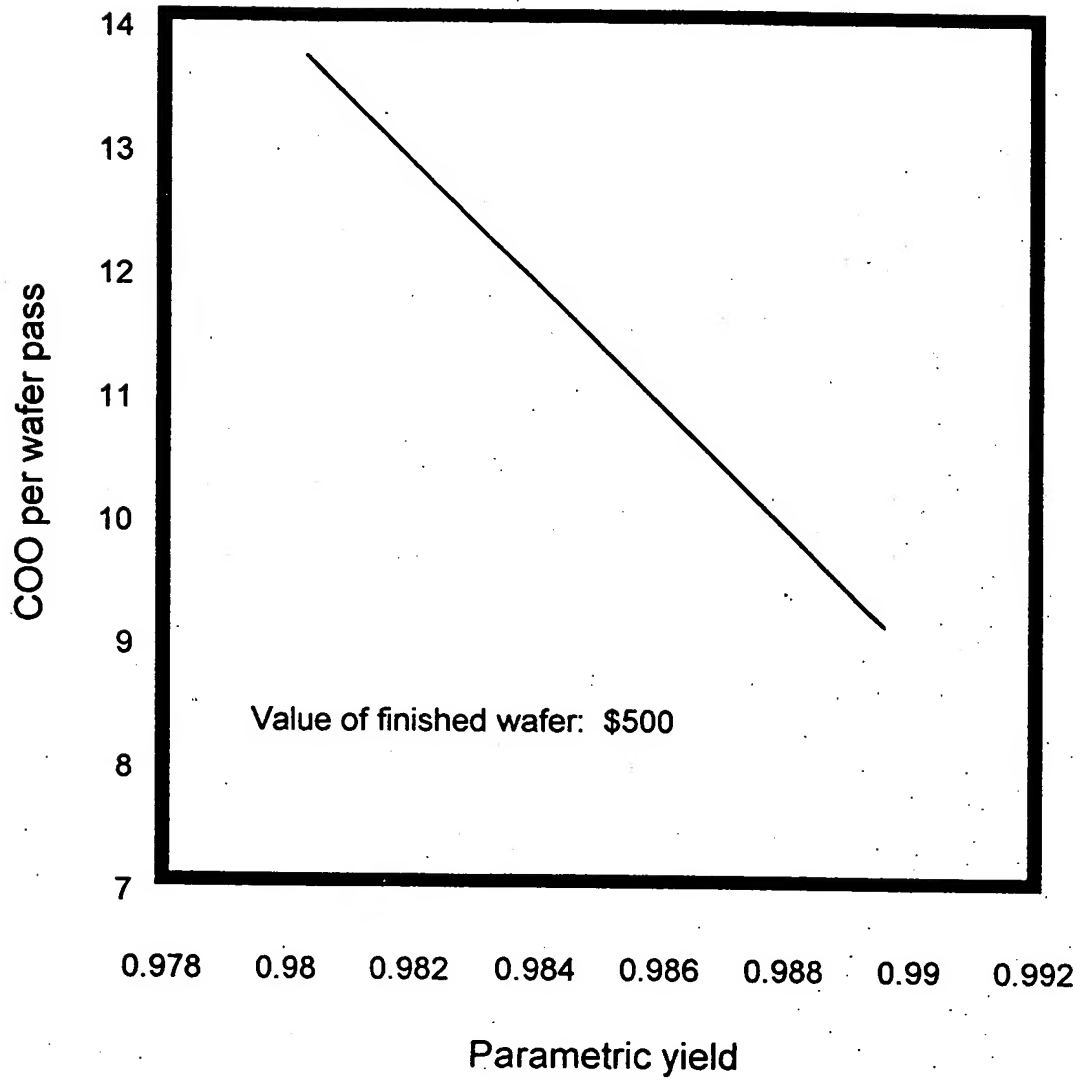
**Figure 8 Cost of ownership
vs defect density**



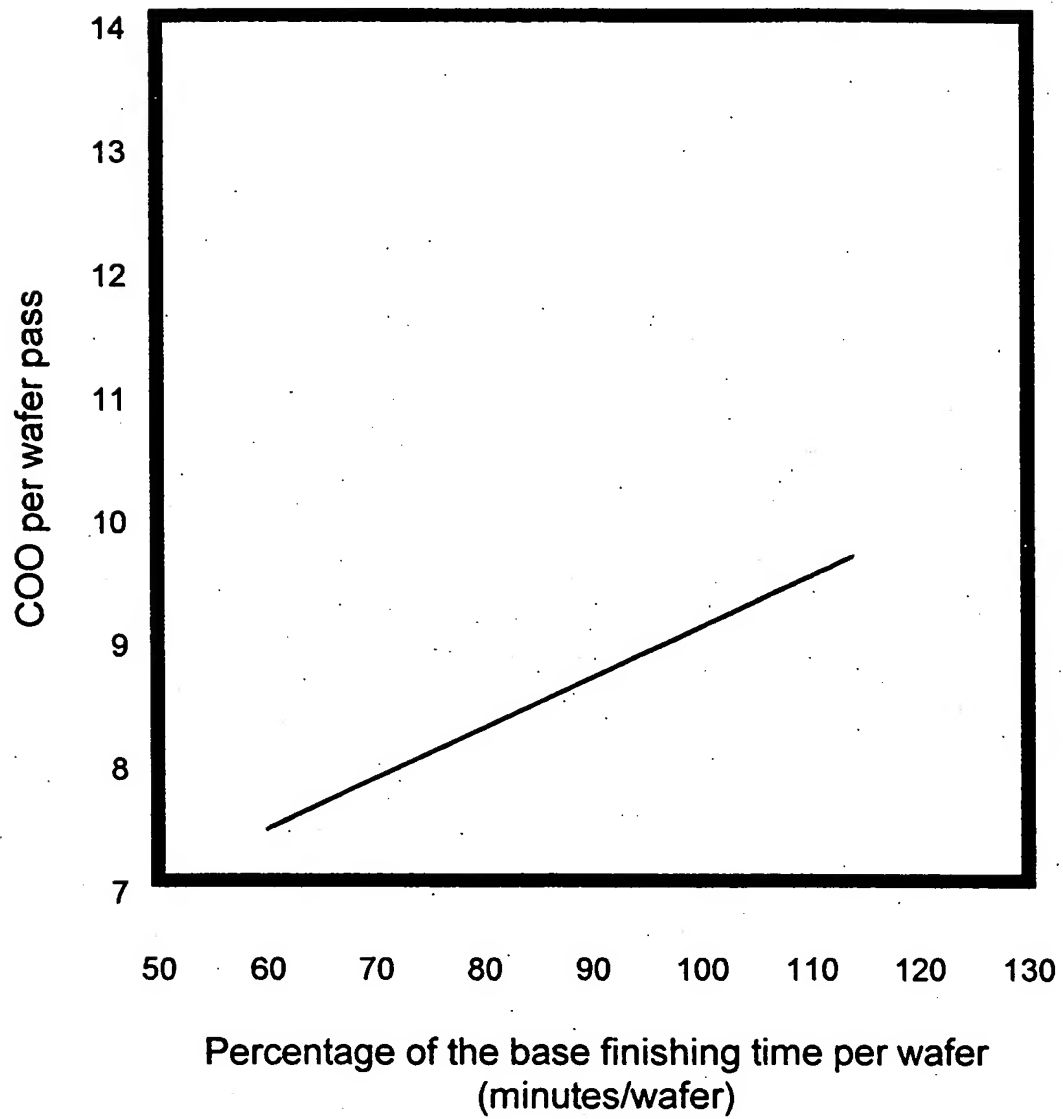
**Figure 9 Cost of ownership
vs equipment yield**



**Figure 10 Cost of ownership
vs parametric yield**



**Figure 11 Cost of ownership
vs wafer polishing rate**



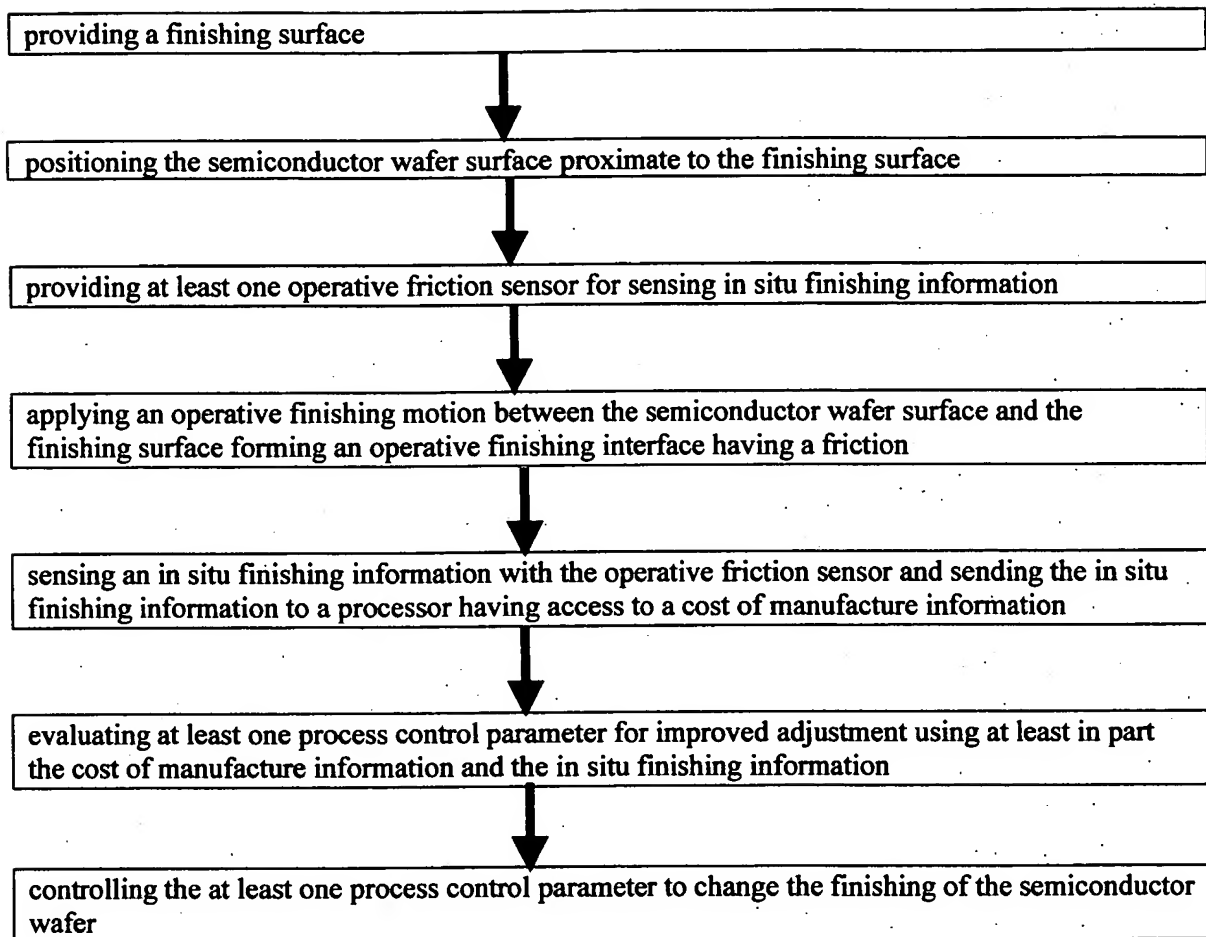


Figure 12

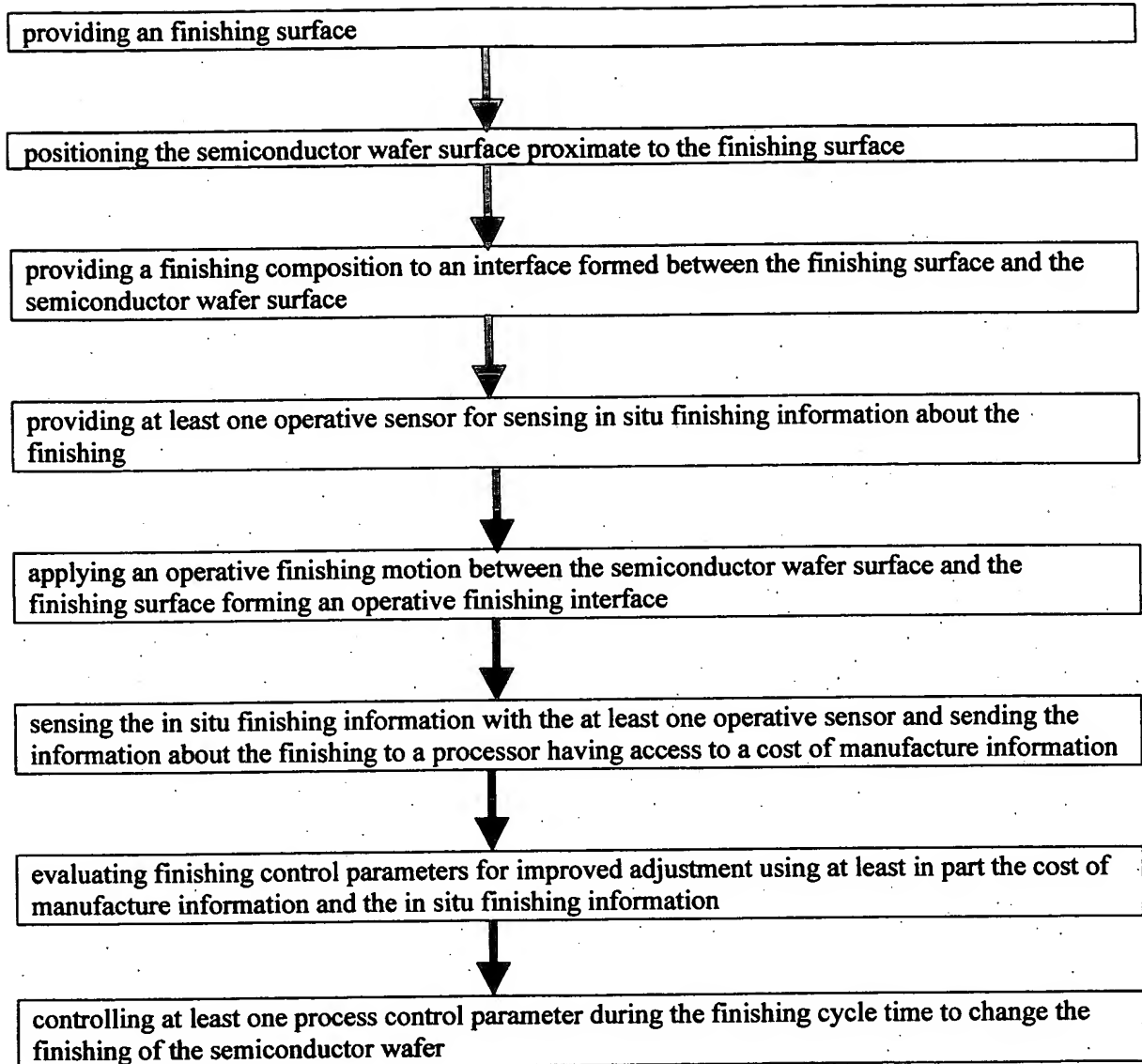


Figure 13

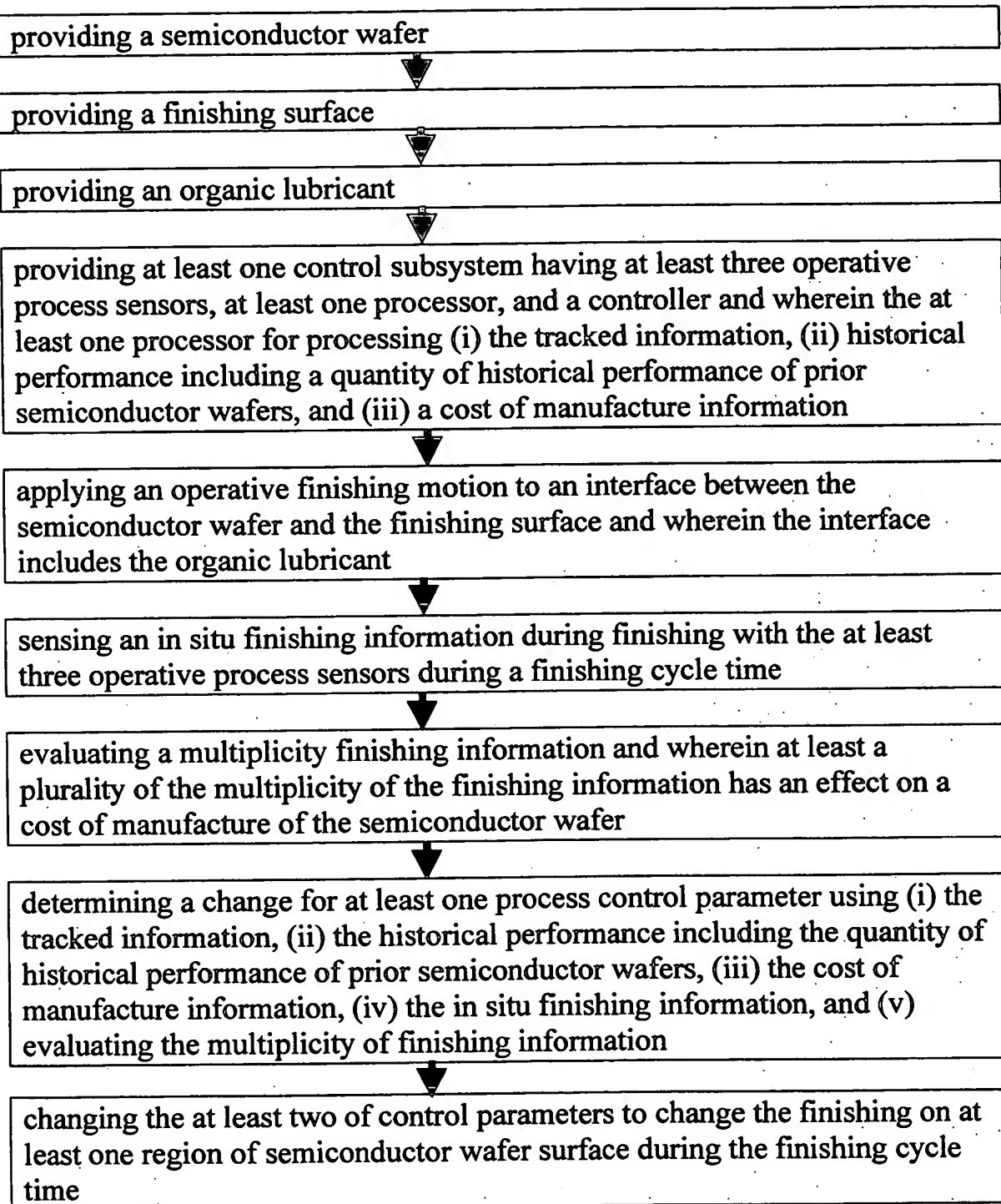


Figure 14

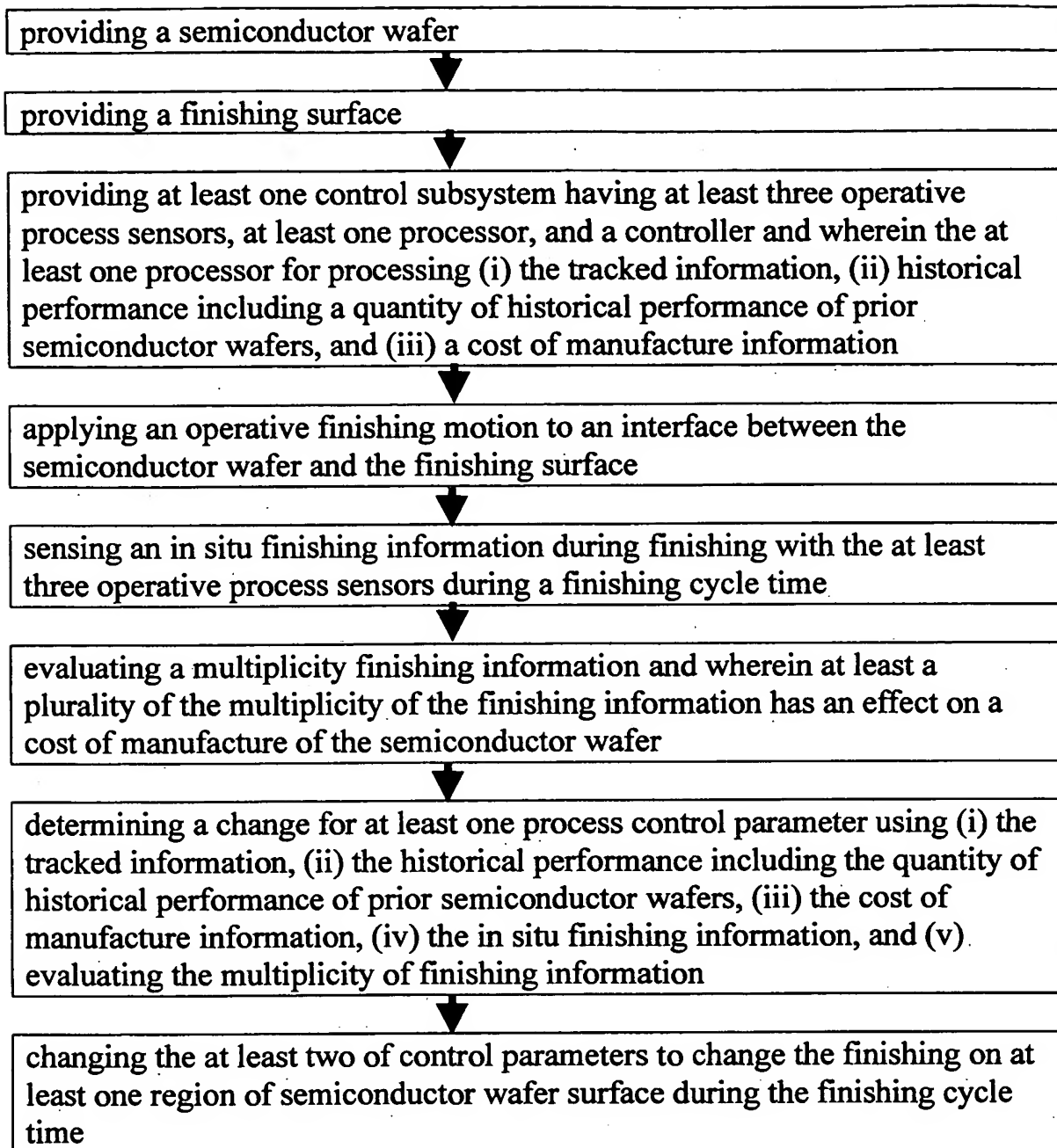


Figure 15

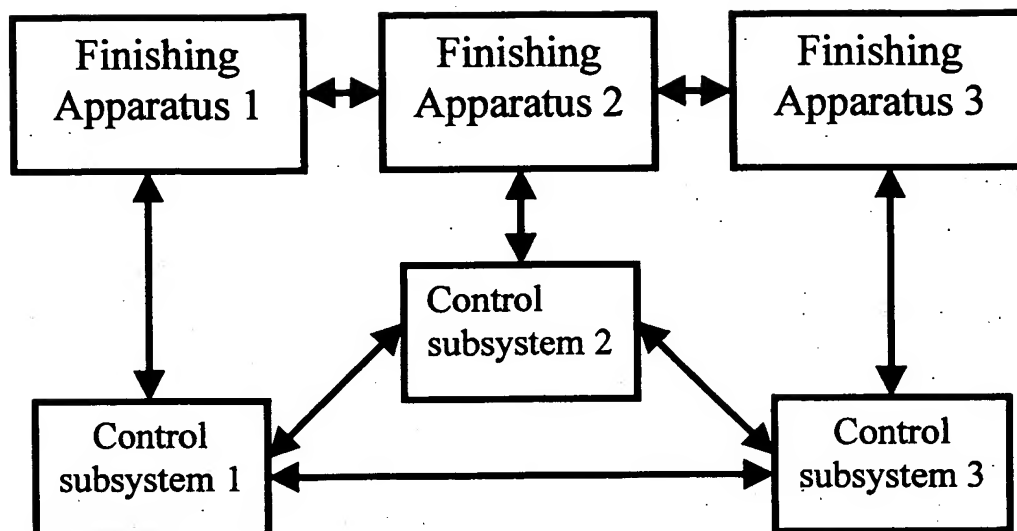


Figure 16a

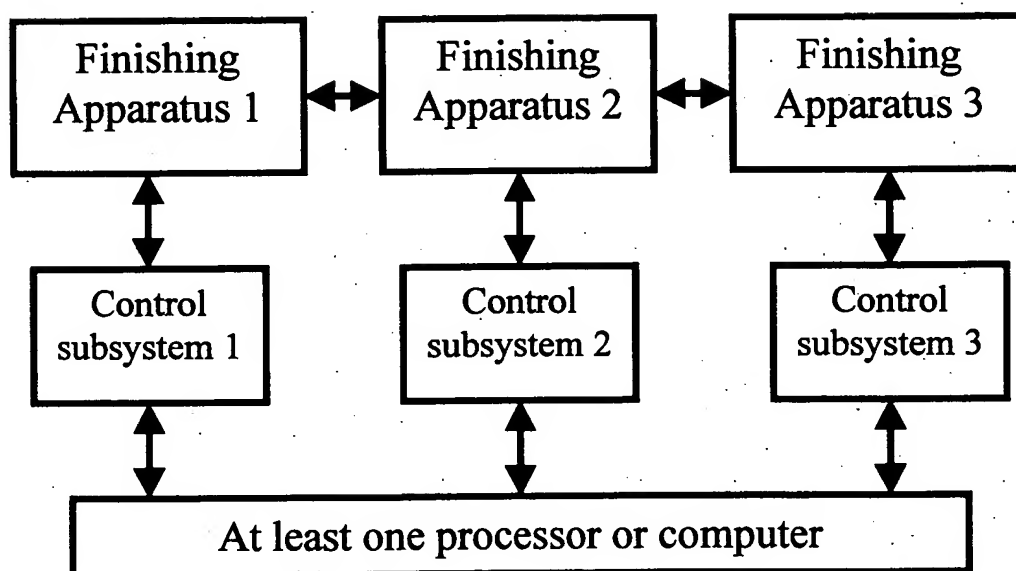


Figure 16b